SHIGA7.055APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Hirayama et al.

Appl. No.

10/590,046

Filed

June 15, 2007

For:

BASE MATERIAL FOR

PATTERN-FORMING

MATERIAL, POSITIVE RESIST COMPOSITION AND METHOD

OF RESIST PATTERN

FORMATION

Examiner

Johnson, C.

Group Art Unit

1795

SUBMISSION WITH RCE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed April 24, 2009, please amend the above-referenced application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.